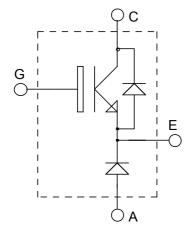


# ISOTOP<sup>®</sup> Buck chopper NPT IGBT

$$V_{CES} = 600V$$
  
 $I_{C} = 30A$  @ Tc = 100°C





#### Application

- AC and DC motor control
- Switched Mode Power Supplies

#### Features

- Non Punch Through (NPT) THUNDERBOLT IGBT
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 100 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
  - ISOTOP<sup>®</sup> Package (SOT-227)
  - Very low stray inductance
  - High level of integration

#### Benefits

- Outstanding performance at high frequency operation
- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive T<sub>C</sub> of V<sub>CEsat</sub>
- RoHS Compliant

#### Absolute maximum ratings

Symbol	Parameter			Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Breakdown Voltage			600	V
I <sub>C1</sub>	- Continuous Collector Current $\frac{T_{C} = 25^{\circ}C}{T_{C} = 100^{\circ}C}$		58		
I <sub>C2</sub>			$T_{\rm C} = 100^{\circ}{\rm C}$	30	А
I <sub>CM</sub>	Pulsed Collector Current	110			
V <sub>GE</sub>	Gate – Emitter Voltage			±20	V
PD	Maximum Power Dissipation T <sub>C</sub>		$T_C = 25^{\circ}C$	192	W
I <sub>LM</sub>	RBSOA clamped Inductive load Current $R_G=11\Omega$		$T_C = 25^{\circ}C$	60	А
IF <sub>AV</sub>	Maximum Average Forward Current	Duty cycle=0.5	$T_C = 80^{\circ}C$	30	А
IF <sub>RMS</sub>	RMS Forward Current (Square wave, 50% duty)			39	Λ

💱 🚓 UTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.



## All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

## **Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V$	$T_j = 25^{\circ}C$			40	
		$V_{CE} = 600 V$	$T_j = 125^{\circ}C$			1000	μA
V <sub>CE(sat)</sub>	Collector Emitter saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		2.0	2.5	V
		$I_{\rm C} = 30 {\rm A}$ $T_{\rm j} = 125 {\rm ^{\circ}C}$	$T_{j} = 125^{\circ}C$		2.2	2.8	v
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 700 \mu A$		3	4	5	V
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = \pm 20 V, V_{CE} = 0 V$				±100	nA

## **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$		1600	1850	
C <sub>oes</sub>	Output Capacitance	$V_{CE} = 25V$		150	220	pF
C <sub>res</sub>	Reverse Transfer Capacitance	f=1MHz		90	150	
Qg	Total gate Charge	$V_{GS} = 15V$		140	210	
Q <sub>ge</sub>	Gate – Emitter Charge	$V_{Bus} = 300V$		10	15	nC
Q <sub>gc</sub>	Gate – Collector Charge	$I_C = 30A$		60	90	
T <sub>d(on)</sub>	Turn-on Delay Time	Resistive Switching (25°C)		13	26	ns
T <sub>r</sub>	Rise Time	$V_{GE} = 15V$ $V_{GE} = 200V$		41	80	
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 300V$ $I_C = 30A$		147	220	
T <sub>f</sub>	Fall Time	$R_{G} = 10\Omega$		200	400	
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (25°C) $V_{GE} = 15V$ $V_{Bus} = 400V$ $I_C = 30A$ $R_G = 10\Omega$		17	30	ns
Tr	Rise Time			28	60	
T <sub>d(off)</sub>	Turn-off Delay Time			242	360	
T <sub>f</sub>	Fall Time			34	70	
Ets	Total switching Losses			1.2	2	mJ
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (150°C)		15	30	
Tr	Rise Time	$V_{GE} = 15V$		27	50	
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 400V$ $I_{C} = 30A$ $R_{G} = 10\Omega$		265	400	ns
T <sub>f</sub>	Fall Time			41	80	
Eon	Turn-on Switching Energy			0.5	1	
E <sub>off</sub>	Turn-off Switching Energy			1	2	mJ
E <sub>ts</sub>	Total switching Losses			1.5	3	

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### Chopper diode ratings and characteristics

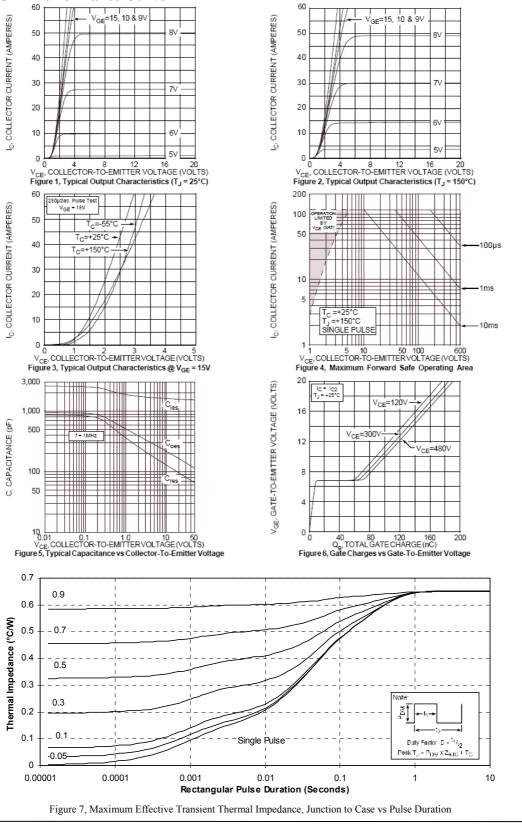
Symbol	Characteristic	<b>Test Conditions</b>		Min	Тур	Max	Unit
	Diode Forward Voltage	$I_F = 30A$			1.6	1.8	
$V_{\rm F}$		$I_F = 60A$			1.9		V
		$I_F = 30A$	$T_{i} = 125^{\circ}C$		1.4		
I <sub>RM</sub>	Maximum Reverse Leakage Current	$V_{R} = 600 V$	$T_j = 25^{\circ}C$			250	μA
IRM		$V_{R} = 600 V$	$T_{j} = 125^{\circ}C$			500	μΛ
CT	Junction Capacitance	$V_{R} = 200 V$			44		pF
4	Reverse Recovery Time	$I_F=1A, V_R=30V$ di/dt =100A/µs	$T_j = 25^{\circ}C$		23		
t <sub>rr</sub>	Reverse Recovery Time	$I_{F} = 30A$ $T_{i} = 25^{\circ}C$ $T_{i} = 125^{\circ}C$ $T_{j} = 25^{\circ}C$	$T_i = 25^{\circ}C$		85		ns
				160			
I <sub>RRM</sub>	Maximum Reverse Recovery Current			4		А	
IRRM	Maximum Reverse Recovery Current	$V_{\rm R} = 400 V$	$T_{i} = 125^{\circ}C$		8		Л
0	Paulana Pagayany Changa	$di/dt = 200 A/\mu s$	$T_j = 25^{\circ}C$		130	n	тС
Q <sub>rr</sub>	Reverse Recovery Charge		$T_{j} = 125^{\circ}C$		700		IIC
t <sub>rr</sub>	Reverse Recovery Time	$I_F = 30A$ $V_R = 400V$ $di/dt = 1000A/\mu s$			70		ns
Q <sub>rr</sub>	Reverse Recovery Charge		$T_{j} = 125^{\circ}C$		1300		nC
I <sub>RRM</sub>	Maximum Reverse Recovery Current				30		Α

## Thermal and package characteristics

Symbol	Characteristic		Min	Тур	Max	Unit	
R <sub>thJC</sub>	Junction to Case Thermal Resistance	IGBT			0.65	°C/W	
		Diode			1.21		
R <sub>thJA</sub>	Junction to Ambient (IGBT & Diode)				20		
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz		2500			V	
$T_J, T_{STG}$	Storage Temperature Range		-55		150	°C	
T <sub>L</sub>	Max Lead Temp for Soldering:0.063" from case for 10 sec				300		
Torque	Mounting torque (Mounting = 8-32 or 4mm Machine and terminals = 4mm Machine)				1.5	N.m	
Wt	Package Weight			29.2		g	



#### **Typical IGBT Performance Curve**

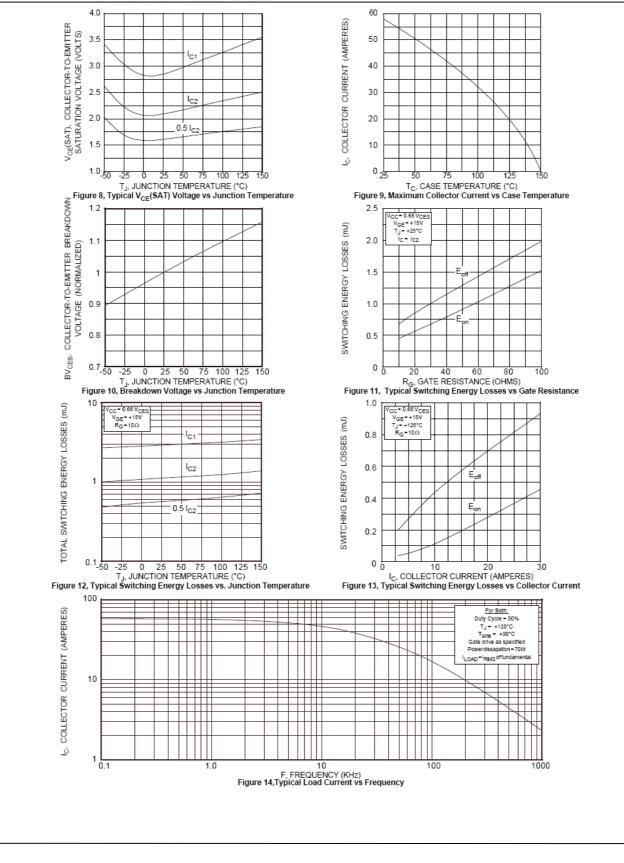


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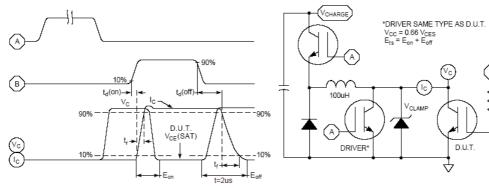


Figure 15, Switching Loss Test Circuit and Waveforms

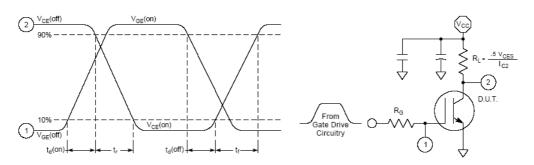
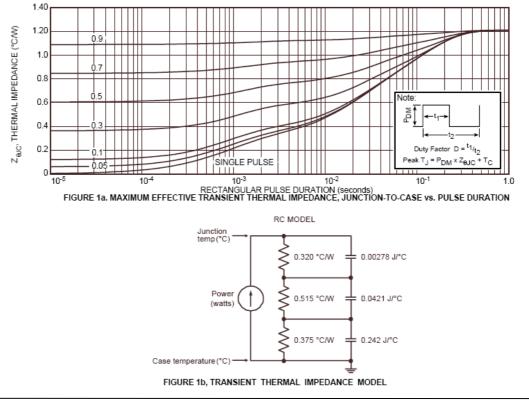


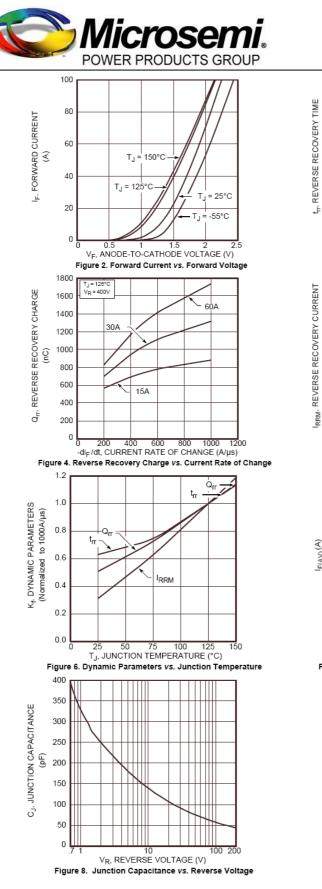
Figure 16, Resistive Switching Time Test Circuit and Waveforms

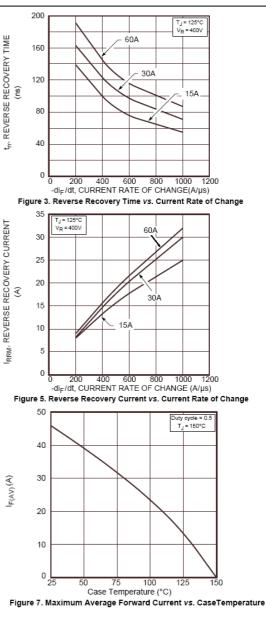


#### **Typical Diode Performance Curve**

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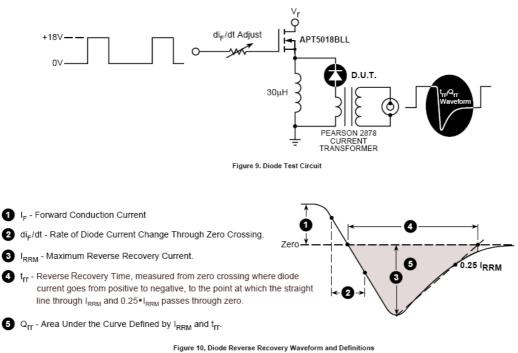


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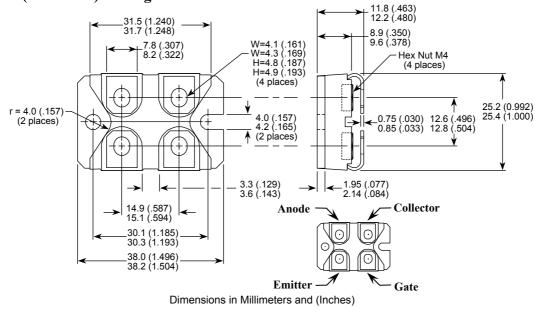
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## SOT-227 (ISOTOP<sup>®</sup>) Package Outline



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